

600V N-Channel MOSFET

Description

The MSU2N60S is a N-channel enhancement-mode MOSFET, providing the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost effectiveness. The TO-251 package is universally preferred for all commercial-industrial applications

Features

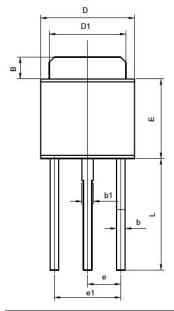
- Rugged Gate Oxide Technology
- · Extremely Low Intrinsic Capacitances
- · Remarkable Switching Characteristics
- Unrivalled Gate Charge: 9.5nC (Typ.)
- · Extended Safe Operating Area
- Lower RDS(ON): 4.0 Ω (Typ.) @VGS=10V
- 100% EAS Test
- · RoHS compliant package

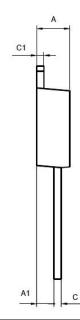
Packing & Order Information

80/Tube; 4,000/Box



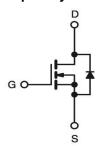






	Dimens	ions in	Dimensions in		
	Millim	eters	Inches		
Symbol	min	max	min	max	
А	2.15	2.45	0.85	0.96	
A1	1.00	1.40	0.39	0.55	
В	1.25	1.75	0.49	0.69	
b	0.45	0.75	0.18	0.3	
b1	0.65	0.95	0.26	0.37	
С	0.38	0.64	0.15	0.25	
C1	0.38	0.64	0.15	0.25	
D	6.30	6.70	2.48	2.64	
D1	5.10	5.50	2.01	2.17	
Е	5.30	5.70	2.09	2.24	
е	2.3 (typ.)	0.91 (t	yp.)	
e1	4.4	4.8	1.73	1.89	
L	7.4	8.0	2.91	3.15	

Graphic symbol





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MAXIMUM RATINGS AND ELECTRICAL CHARACTERISTICS

Absolute Maximum Ratings (Tc=25°C unless otherwise noted)						
Symbol	Parameter	Value	Unit			
V_{DSS}	Drain-Source Voltage	600	V			
V_{GS}	Gate-Source Voltage	±30	V			
1	Drain Current -Continuous (TC=25°C)	2	А			
I _D	Drain Current -Continuous (TC=100°C)	1.1	Α			
I _{DM}	Drain Current Pulsed	7.6	А			
E _{AS}	Single Pulsed Avalanche Energy	60	mJ			
E _{AR}	Repetitive Avalanche Energy	4.4	mJ			
dV/dt	Peak Diode Recovery dV/dt	4.5	V/ns			
D	Power Dissipation (TC = 25 °C)	44	W			
P_D	- Derate above 25°C	0.35	W/°C			
T _J ,T _{STG}	Operating and Storage Temperature Range	-55 to +150	°C			
T _L	Maximum lead temperature for soldering purposes,	200	%C			
	1/8" from case for 5 seconds	300	°C			

• Drain current limited by maximum junction temperature

Thermal Resistance Characteristics						
Symbol	Parameter	Max.	Units			
$R_{\theta J}c$	Junction-to-Case	2.87	90044			
$R_{\theta JA}$	Junction-to-Ambient	83.3	- °C/W			

On Characteristics							
Symbol Parameter Test Conditions Min				Тур.	Max.	Units	
V_{GS}	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_{D} = 250 \mu A$	2.0		4.0	V	
R _{DS(ON)}	Static Drain-Source On-Resistance	$V_{GS} = 10 \text{ V}, I_{D} = 1 \text{ A}$		4.0	4.7	Ω	

Off Characteristics						
Symbol	Parameter	Test Conditions	Min	Тур.	Max.	Units
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu A$	600			V
ΔBV_{DSS} / ΔT_{J}	Breakdown Voltage Temperature Coefficient	I _D = 250μA, Referenced to 25°C		0.6		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 600 \text{ V}$, $V_{GS} = 0 \text{ V}$ $V_{DS} = 480 \text{ V}$, $T_{C} = 125 ^{\circ}\text{C}$			1 10	μA
I _{GSSF}	Gate-Body Leakage Current, Forward	$V_{GS} = 30 \text{ V} , V_{DS} = 0 \text{ V}$			100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = -30 V , V _{DS} = 0 V			-100	nA



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Dynamic	Dynamic Characteristics							
Symbol	Parameter	Test Conditions	Min	Тур.	Max.	Units		
C_{ISS}	Input Capacitance			180	235	pF		
Coss	Output Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ F = 1.0 MHz		20	25	pF		
C _{RSS}	Reverse Transfer Capacitance	1 - 1.000112		4.3	5.6	pF		
$t_{d(on)}$	Turn-On Time			25	60	ns		
t _r	Turn-On Time	$V_{DS} = 300 \text{ V}, I_D = 2 \text{ A},$		24	58	ns		
$t_{\text{d(off)}}$	Turn-Off Delay Time	$R_G = 25 \Omega$		28	66	ns		
tf	Turn-Off Fall Time			28	70	ns		
Q_g	Total Gate Charge	$V_{DS} = 480 \text{ V}, I_{D} = 2 \text{ A},$ $V_{GS} = 10 \text{ V}$		9.5	13	nC		
Q _{gs}	Gate-Source Charge			1.6		nC		
Q_{gd}	Gate-Drain Charge			4		nC		

Source-Drain Diode Maximum Ratings and Characteristics							
Symbol	Parameter	Test Conditions	Min	Тур.	Max.	Units	
Is	Continuous Source-Drain Diode Forward Current				1.9		
I _{SM}	Pulsed Source-Drain Diode Forward Current				7.9	- A	
V _{SD}	Source-Drain Diode Forward Voltage	I _S = 2 A , V _{GS} = 0 V			1.4	V	
t _{rr}	Reverse Recovery Time	I _S = 2 A , V _{GS} = 0 V		230		ns	
Q _{rr}	Reverse Recovery Charge	diF/dt = 100A/µs		1.0		μC	

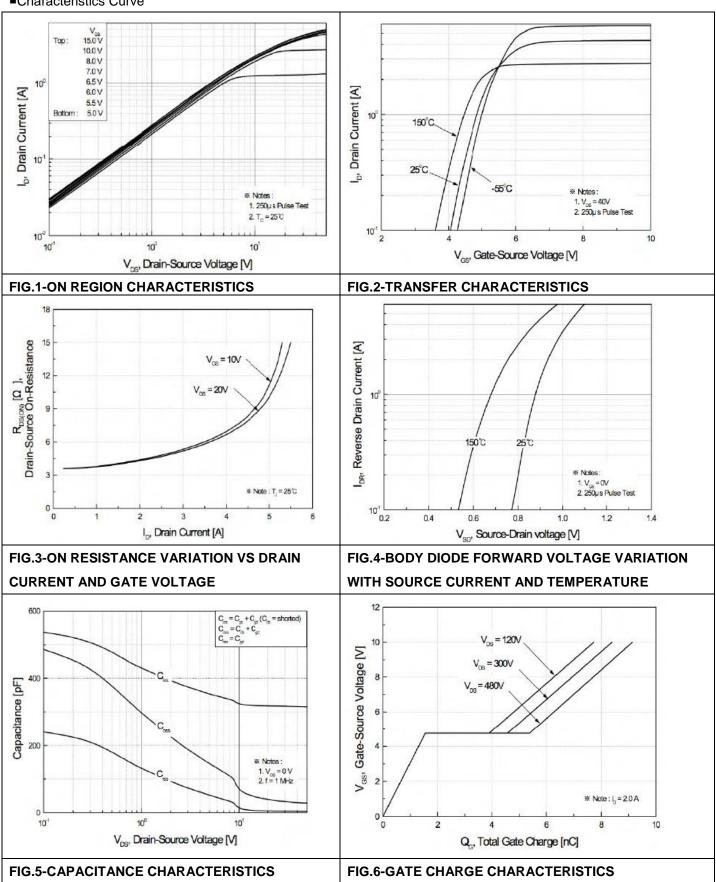
Notes;

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. I_{AS} =1.6A, V_{DD} =50V, R_{G} =25W, Starting T_{J} =25°C
- 3. I_{SD} \leq 1.6A, di/dt \leq 300A/ μ s, V_{DD} \leq BV_{DSS}, Starting T_J =25°C
- 4. Pulse Test: Pulse Width ≦ 300µs, Duty Cycle≦ 2%
- 5. Essentially Independent of Operating Temperature



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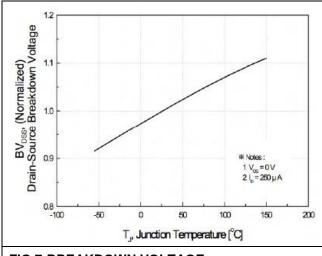
■Characteristics Curve





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■Characteristics Curve



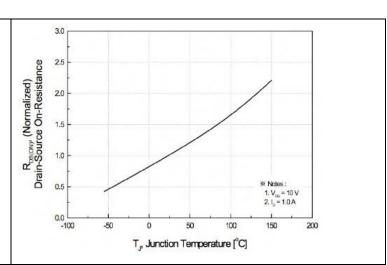


FIG.7-BREAKDOWN VOLTAGE VARIATION VS TEMPERATURE

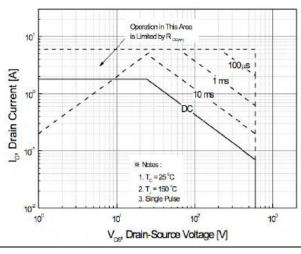


FIG.8-ON-RESISTANCE VARIATION VS TEMPERATURE

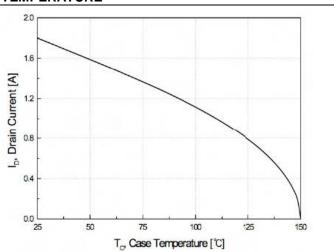
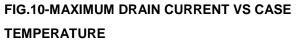


FIG.9-MAXIMUM SAFE OPERATING AREA



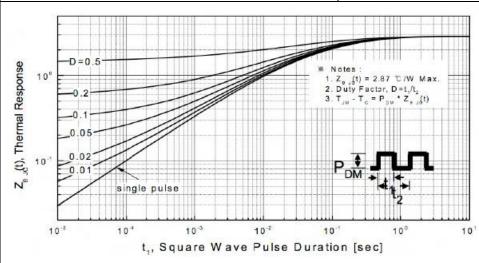


FIG.11-TRANSIENT THERMAL RESPONSE CURVE



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■Characteristics Test Circuit & Waveform

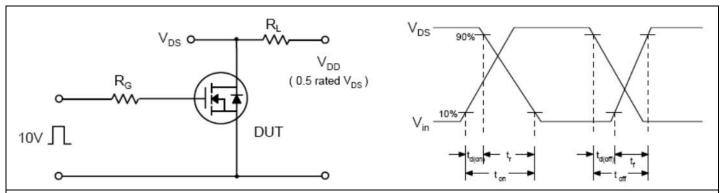


FIG.12-RESISTIVE SWITCHING TEST CIRCUIT & WAVEFORMS

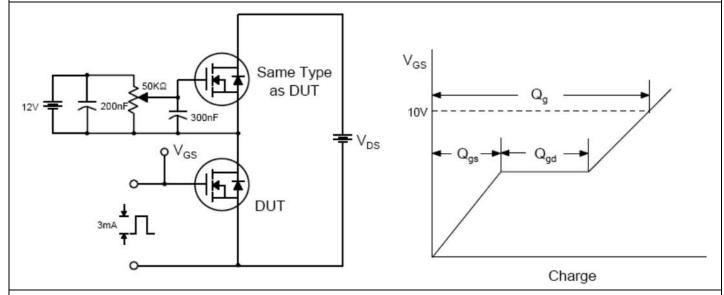


FIG.13-GATE CHARGE TEST CIRCUIT & WAVEFORM

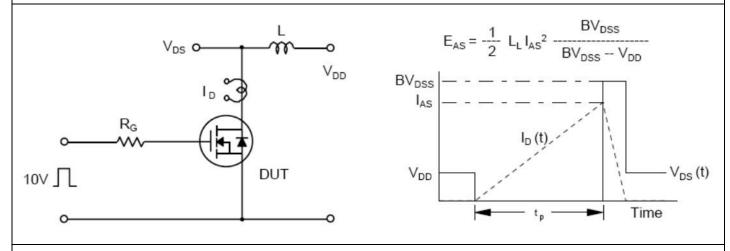


FIG.14-UNCLAMPED LINDUCTIVE SWITCHING TEST CIRCUIT & WAVEFORMS



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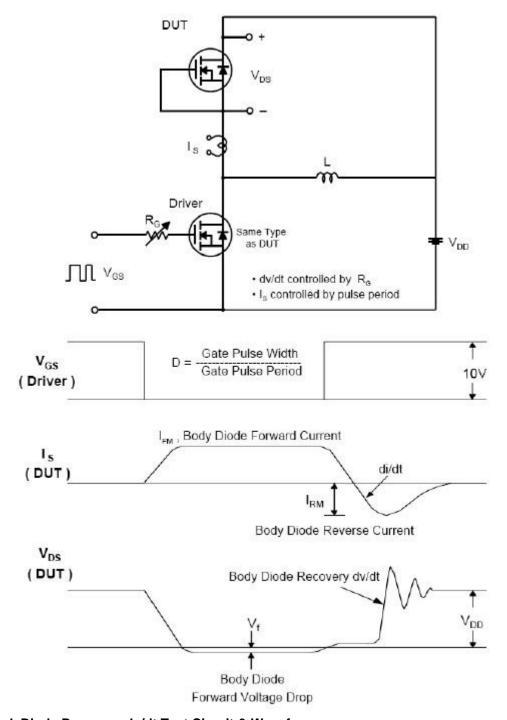


Fig 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms



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